



TEST REPORT

Report Reference No.: **TRE1710006701** R/C.....: 74712

FCC ID: **U5W-BTS-007**

Applicant's name: **Primo International Co., Ltd.**

Address: Room 2509, Ginza International Building 7008 Shennan Road, Shenzhen,China

Manufacturer.....: Primo International Co., Ltd.

Address.....: Room 2509, Ginza International Building 7008 Shennan Road, Shenzhen,China

Test item description: **True wireless earphone**

Trade Mark.....: -

Model/Type reference: BTS-007

Listed Model(s).....: -

Standard.....: **FCC CFR Title 47 Part 15 Subpart C Section 15.247**

Date of receipt of test sample.....: Oct. 17, 2017

Date of testing.....: Oct. 18, 2017- Oct. 30, 2017

Date of issue.....: Oct. 30, 2017

Result.....: **PASS**

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Jerry Wang

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Hans Hu

Testing Laboratory Name.....: **Shenzhen Huatongwei International Inspection Co., Ltd.**

Address: 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China

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The test report merely corresponds to the test sample.

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1. TEST STANDARDS AND TEST DESCRIPTION

1.1. Test Standards

The tests were performed according to following standards:

[FCC Rules Part 15.247](#): Frequency Hopping, Direct Spread Spectrum and Hybrid Systems that are in operation within the bands of 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz.

[ANSI C63.10-2013](#): American National Standard for Testing Unlicensed Wireless Devices

1.2. Report version

Version No.	Date of issue	Description
00	Oct. 30, 2017	Original

2. TEST DESCRIPTION

Test Item	Section in CFR 47	Result
Antenna Requirement	15.203/15.247 (c)	Pass
AC Power Line Conducted Emissions	15.207	N/A
Conducted Peak Output Power	15.247 (b)(1)	Pass
20dB Occupied Bandwidth	15.247 (a)(1)	Pass
Carrier Frequencies Separation	15.247 (a)(1)	Pass
Hopping Channel Number	15.247 (a)(1)	Pass
Dwell Time	15.247 (a)(1)	Pass
Pseudorandom Frequency Hopping Sequence	15.247(b)(4)	Pass
Restricted band	15.247(d)/15.205	Pass
Radiated Emissions	15.247(d)/15.209	Pass

Note: The measurement uncertainty is not included in the test result.

N/A means not applicable.

3. SUMMARY

3.1. Client Information

Applicant:	Primo International Co., Ltd.
Address:	Room 2509, Ginza International Building 7008 Shennan Road, Shenzhen, China
Manufacturer:	Primo International Co., Ltd.
Address:	Room 2509, Ginza International Building 7008 Shennan Road, Shenzhen, China

3.2. Product Description

Name of EUT	True wireless earphone
Trade Mark:	-
Model No.:	BTS-007
Listed Model(s):	-
Power supply:	DC 5V for USB port and DC 3.7V for internal battery
Adapter information:	-
Software Version:	HES014_MSD-M015_L_V1.0W
Hardware Version:	HES14_M015_V1.0W_M015_D1_170825_01_SVN25433_(V1_7)
Bluetooth	
Version:	Supported BT4.2+EDR
Modulation:	GFSK, $\pi/4$ DQPSK, 8DPSK
Operation frequency:	2402MHz~2480MHz
Channel number:	79
Channel separation:	1MHz
Antenna type:	Internal Antenna
Antenna gain:	0.5dBi

3.3. Operation state

➤ Test frequency list

According to section 15.31(m), regards to the operating frequency range over 10 MHz, must select three channel which were tested. the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, please see the above gray bottom.

Channel	Frequency (MHz)
0	2402
1	2403
:	:
39	2441
:	:
77	2479
78	2480

➤ Test mode

For RF test items
The engineering test program was provided and enabled to make EUT continuous transmit.
For AC power line conducted emissions:
The EUT was set to connect with the Bluetooth under large package sizes transmission.
For RF test axis
EUT in each of three orthogonal axis emissions had been tested ,but only the worst case (X axis) data Recorded in the report.

3.4. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

- - supplied by the manufacturer
- - supplied by the lab

	Manufacturer :	/
	Model No. :	/
	Manufacturer :	/
	Model No. :	/

3.5. Modifications

No modifications were implemented to meet testing criteria.

4. Test Environment

4.1. Address of the test laboratory

Laboratory: Shenzhen Huatongwei International Inspection Co., Ltd.

Address: 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China

Phone: 86-755-26748019 Fax: 86-755-26748089

4.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L1225

Shenzhen Huatongwei International Inspection Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories.

A2LA-Lab Cert. No. 3902.01

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

FCC-Registration No.: 762235

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 762235.

IC-Registration No.: 5377B-1

Two 3m Alternate Test Site of Shenzhen Huatongwei International Inspection Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 5377B-1.

ACA

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory can also perform testing for the Australian C-Tick mark as a result of our A2LA accreditation.

4.3. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature:	15~35°C
Relative Humidity:	30~60 %
Air Pressure:	950~1050mba

4.4. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors in calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report according to TR-100028-01 "Electromagnetic compatibility and Radio spectrum Matters (ERM); Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM); Uncertainties in the measurement of mobile radio equipment characteristics; Part 2" and is documented in the Shenzhen Huatongwei International Inspection Co., Ltd quality system according to ISO/IEC 17025. Further more, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Here after the best measurement capability for Shenzhen Huatongwei is reported:

Test Items	Measurement Uncertainty	Notes
Transmitter power conducted	0.57 dB	(1)
Transmitter power Radiated	2.20 dB	(1)
Conducted spurious emissions 9KHz-40 GHz	1.60 dB	(1)
Radiated spurious emissions 9KHz-40 GHz	2.20 dB	(1)
Conducted Emissions 9KHz-30MHz	3.39 dB	(1)
Radiated Emissions 30~1000MHz	4.24 dB	(1)
Radiated Emissions 1~18GHz	5.16 dB	(1)
Radiated Emissions 18-40GHz	5.54 dB	(1)
Occupied Bandwidth	-----	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=1.96.

4.5. Equipments Used during the Test

Line Conducted Emissions (AC Main)					
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	EMI Test Receiver	R&S	ESCI	101247	2016/11/13
2	Artificial Mains	Shwarzbeck	NNLK 8121	573	2016/11/13
3	Pulse Limiter	R&S	ESH3-Z2	101488	2016/11/13
4	Test Software	R&S	ES-K1	N/A	N/A
5	Test cable	ENVIROFLEX	3651	1101902	2016/11/13

Maximum Peak Output Power / Power Spectral Density / 6dB Bandwidth / Band Edge Compliance of RF Emissions / Spurious RF Conducted Emissions					
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal
1	Spectrum Analyzer	Rohde&Schwarz	FSP	1164.4391.40	2016/11/13
2	Power Meter	Anritsu	ML2480B	100798	2016/11/13
3	Power Sensor	Anritsu	MA2411B	100258	2016/11/13
4	Test cable	FARPU	MCX-J	N/A	2016/11/13
5	Temporary antenna connector	D-LENP	NJ-SMAK	N/A	2016/11/13

NOTE: The temporary antenna connector is soldered on the PCB board in order to perform conducted tests and this temporary antenna connector is listed in the equipment list.

Radiated Emissions					
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	EMI Test Receiver	Rohde&Schwarz	ESI 26	100009	2016/11/13
2	RF Test Panel	Rohde&Schwarz	TS / RSP	335015/ 0017	N/A
3	EMI Test Software	Rohde&Schwarz	ESK1	N/A	N/A
4	Loop Antenna	Rohde&Schwarz	HZ-9	838622\013	2016/11/13
5	Ultra-Broadband Antenna	ShwarzBeck	VULB9163	538	2016/11/13
6	Horn Antenna	ShwarzBeck	9120D	1011	2016/11/13
7	Broadband Horn Antenna	Shwarzbeck	BBHA9170	BBHA9170472	2016/11/13
8	Preamplifier	Shwarzbeck	BBV9742	9742-196	2016/11/13
9	Broadband Preamplifier	Shwarzbeck	BBV 9721	9721-102	2016/11/13
10	Broadband Preamplifier	Shwarzbeck	BBV 9718	9718-247	2016/11/13
11	Turn Table	MATURO	TT2.0	/	N/A
12	Antenna Mast	MATURO	TAM-4.0-P	/	N/A
13	EMI Test Software	Audix	E3	N/A	N/A
14	Test Software	R&S	ES-K1	N/A	N/A
15	Test cable	Siva Cables Italy	RG 58A/U	W14.02	2016/11/13

The Cal.Interval was one year

5. TEST CONDITIONS AND RESULTS

5.1. Antenna requirement

Requirement

FCC CFR Title 47 Part 15 Subpart C Section 15.203:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

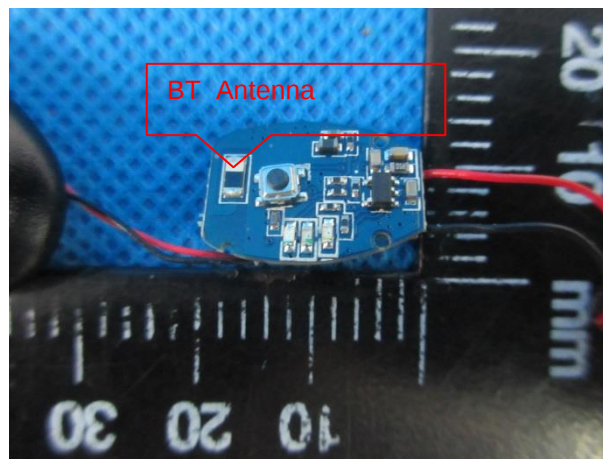
FCC CFR Title 47 Part 15 Subpart C Section 15.247(c) (1)(i):

(i) Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed. Point-to-point operations may employ transmitting antennas with directional gain greater than 6dBi provided the maximum conducted output power of the intentional radiator is reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6dBi.

TEST RESULTS

☒ **Passed** ☐ **Not Applicable**

The directional gain of the antenna less than 6 dBi, please refer to the below antenna photo.



5.2. Conducted Emission (AC Main)

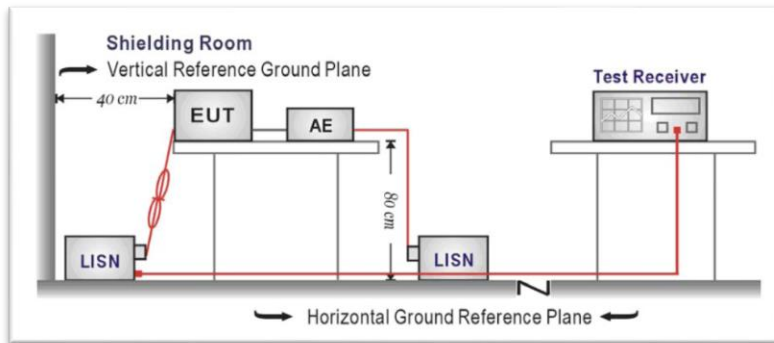
LIMIT

FCC CFR Title 47 Part 15 Subpart C Section 15.207:

Frequency range (MHz)	Limit (dBuV)	
	Quasi-peak	Average
0.15-0.5	66 to 56*	56 to 46*
0.5-5	56	46
5-30	60	50

* Decreases with the logarithm of the frequency.

TEST CONFIGURATION



TEST PROCEDURE

1. The EUT was setup according to ANSI C63.10:2013 for compliance to FCC 47CFR 15.247 requirements.
2. The EUT was placed on a platform of nominal size, 1 m by 1.5 m, raised 80 cm above the conducting ground plane. The vertical conducting plane was located 40 cm to the rear of the EUT. All other surfaces of EUT were at least 80 cm from any other grounded conducting surface.
3. The EUT and simulators are connected to the main power through a line impedances tabilization network (LISN). The LISN provides a 50 ohm /50uH coupling impedance for the measuring equipment.
4. The peripheral devices are also connected to the main power through a LISN. (Please refer to the block diagram of the test setup and photographs)
5. Each current-carrying conductor of the EUT power cord, except the ground (safety) conductor, was individually connected through a LISN to the input power source.
6. The excess length of the power cord between the EUT and the LISN receptacle were folded back and forth at the center of the lead to form a bundle not exceeding 40 cm in length.
7. Conducted emissions were investigated over the frequency range from 0.15MHz to 30MHz using a receiver bandwidth of 9 kHz.
8. During the above scans, the emissions were maximized by cable manipulation.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

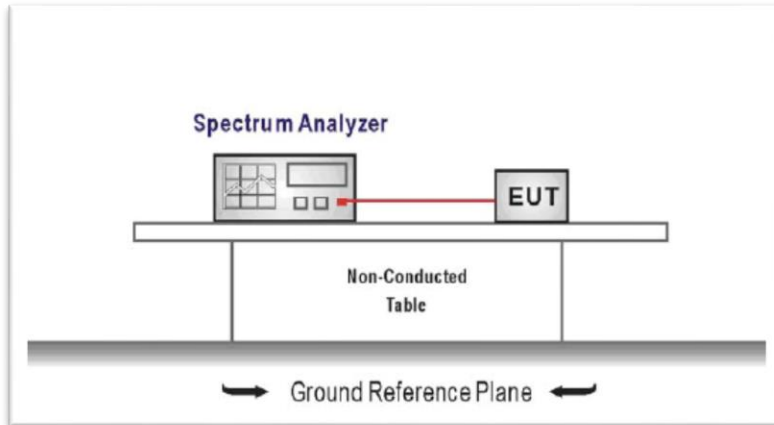
☐ Passed ☒ Not Applicable

5.3. Conducted Peak Output Power

LIMIT

FCC CFR Title 47 Part 15 Subpart C Section 15.247 (b)(3): **30dBm**

TEST CONFIGURATION



TEST PROCEDURE

1. The transmitter output was connected to the spectrum analyzer through an attenuator, the pathloss was compensated to the results for each measurement.
2. Set to the maximum power setting and enable the EUT transmit continuously
3. Use the following spectrum analyzer settings:
Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel
RBW $\geq$ the 20 dB bandwidth of the emission being measured, VBW $\geq$ RBW
Sweep = auto, Detector function = peak, Trace = max hold
4. Measure and record the results in the test report.

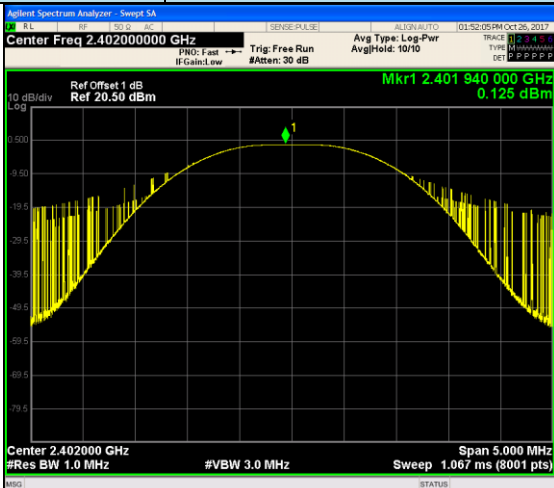
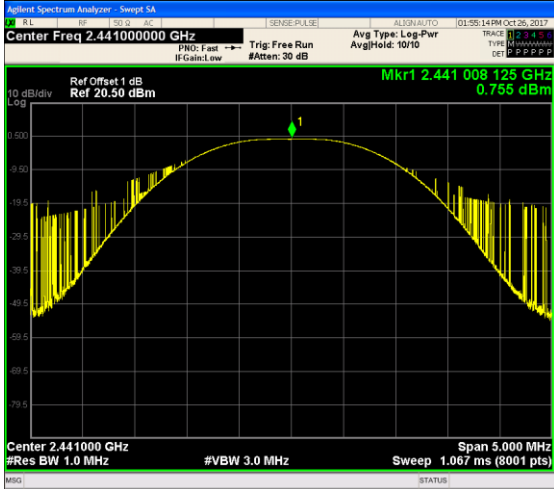
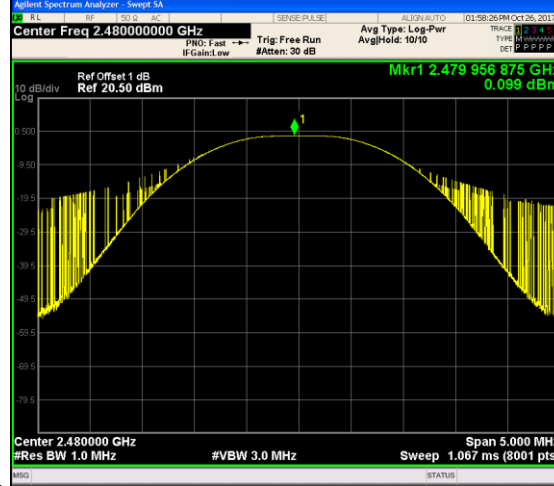
TEST MODE:

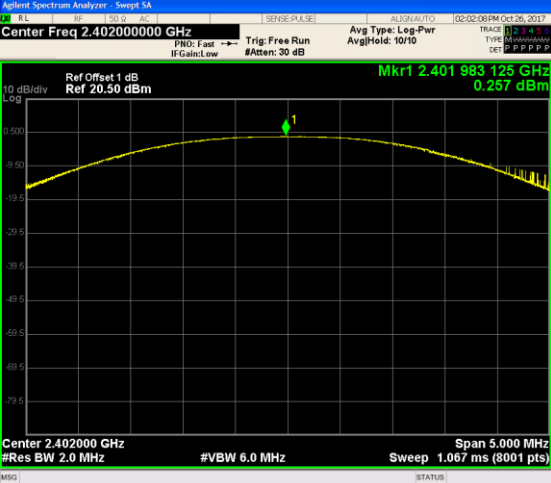
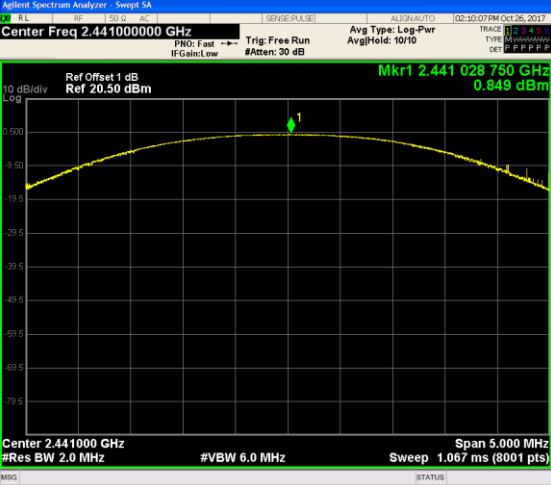
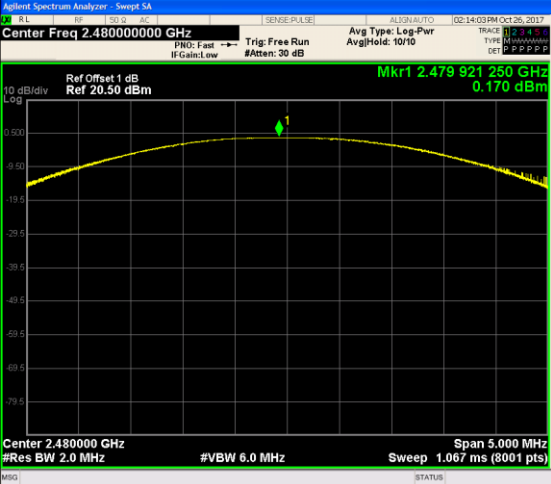
Please refer to the clause 3.3

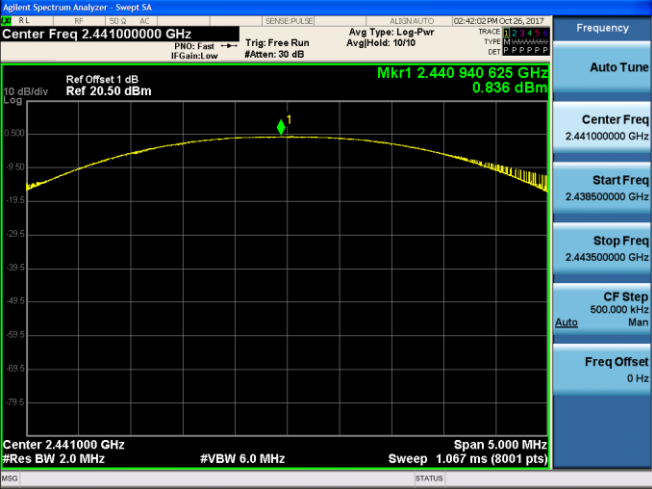
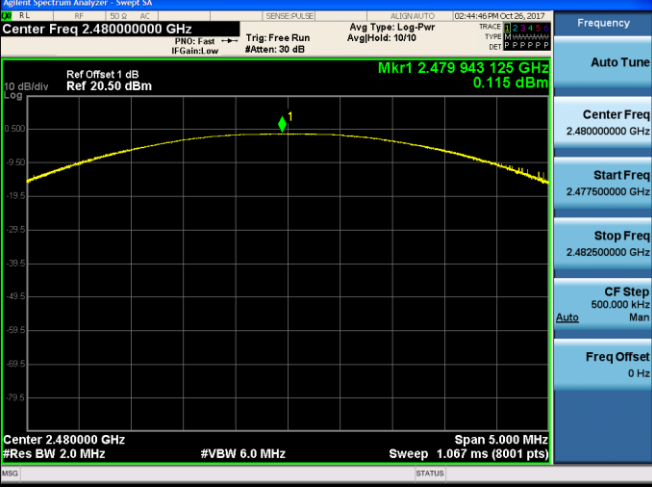
TEST RESULTS

☒ Passed ☐ Not Applicable

Modulation type	Channel	Output power (dBm)	Limit (dBm)	Result
GFSK	00	0.125	30.00	Pass
	39	0.755		
	78	0.099		
$\pi/4$ DQPSK	00	0.257	21.00	Pass
	39	0.849		
	78	0.170		
8DPSK	00	0.198	21.00	Pass
	39	0.836		
	78	0.115		

Modulation Type:		GFSK	
CH00		Frequency Auto Tune Center Freq 2.402000000 GHz Start Freq 2.399500000 GHz Stop Freq 2.404500000 GHz CF Step 500.000 kHz Auto Man Freq Offset 0 Hz	
CH39		Frequency Auto Tune Center Freq 2.441000000 GHz Start Freq 2.439500000 GHz Stop Freq 2.443500000 GHz CF Step 500.000 kHz Auto Man Freq Offset 0 Hz	
CH78		Frequency Auto Tune Center Freq 2.480000000 GHz Start Freq 2.477500000 GHz Stop Freq 2.482500000 GHz CF Step 500.000 kHz Auto Man Freq Offset 0 Hz	

Modulation Type:	$\pi/4$ DQPSK
CH00	 Agilent Spectrum Analyzer - Swept SA Center Freq 2.402000000 GHz Ref Offset 1 dB Ref 20.50 dBm Mkr1 2.401983125 GHz 0.257 dBm Center 2.402000 GHz #Res BW 2.0 MHz #VBW 6.0 MHz Sweep 1.067 ms (8001 pts) Frequency Auto Tune Center Freq 2.402000000 GHz Start Freq 2.399500000 GHz Stop Freq 2.404500000 GHz CF Step 500.000 kHz Auto Man Freq Offset 0 Hz
CH39	 Agilent Spectrum Analyzer - Swept SA Center Freq 2.441000000 GHz Ref Offset 1 dB Ref 20.50 dBm Mkr1 2.441028750 GHz 0.849 dBm Center 2.441000 GHz #Res BW 2.0 MHz #VBW 6.0 MHz Sweep 1.067 ms (8001 pts) Frequency Auto Tune Center Freq 2.441000000 GHz Start Freq 2.438500000 GHz Stop Freq 2.443500000 GHz CF Step 500.000 kHz Auto Man Freq Offset 0 Hz
CH78	 Agilent Spectrum Analyzer - Swept SA Center Freq 2.480000000 GHz Ref Offset 1 dB Ref 20.50 dBm Mkr1 2.479921250 GHz 0.170 dBm Center 2.480000 GHz #Res BW 2.0 MHz #VBW 6.0 MHz Sweep 1.067 ms (8001 pts) Frequency Auto Tune Center Freq 2.480000000 GHz Start Freq 2.477500000 GHz Stop Freq 2.482500000 GHz CF Step 500.000 kHz Auto Man Freq Offset 0 Hz

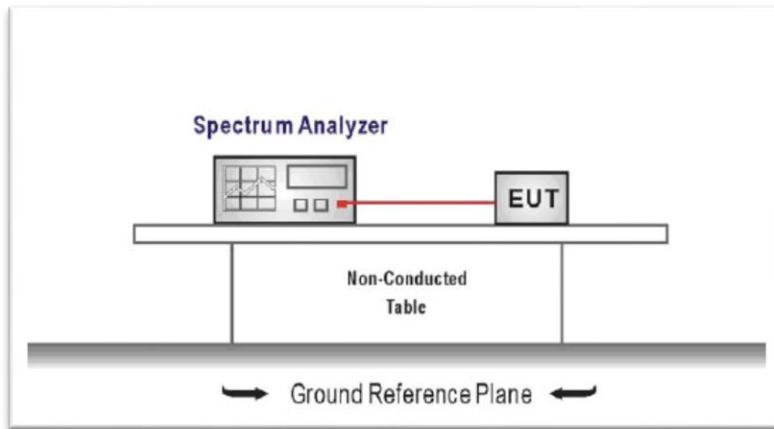
Modulation Type:		8DPSK	
CH00			
CH39			
CH78			

5.4. 20dB Emission Bandwidth

LIMIT

N/A

TEST CONFIGURATION



TEST PROCEDURE

1. The transmitter output was connected to the spectrum analyzer through an attenuator, the pathloss was compensated to the results for each measurement.
2. Set to the maximum power setting and enable the EUT transmit continuously
3. Use the following spectrum analyzer settings:
Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel
RBW $\geq$ 1% of the 20 dB bandwidth, VBW $\geq$ RBW
Sweep = auto, Detector function = peak, Trace = max hold
4. Measure and record the results in the test report.

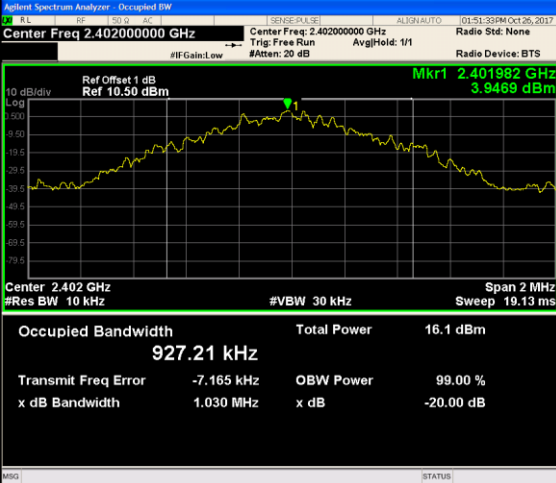
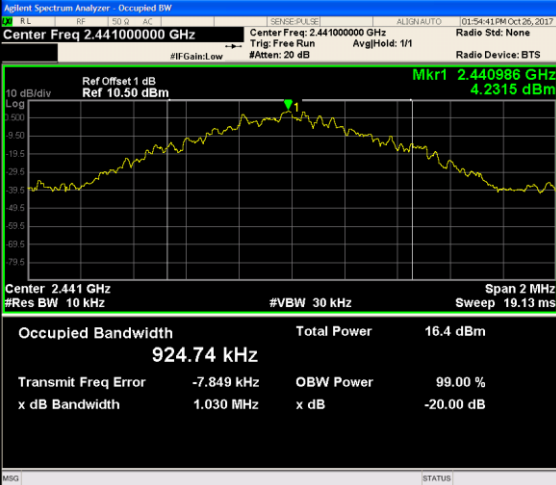
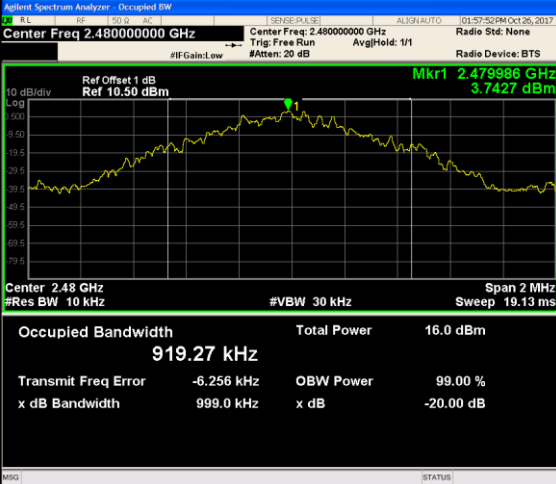
TEST MODE:

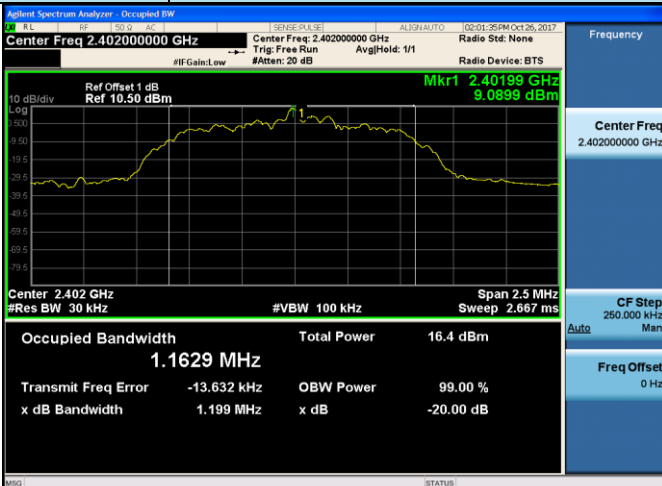
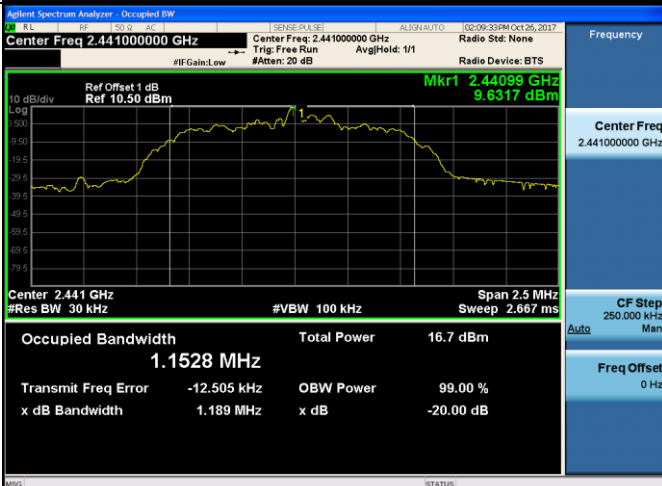
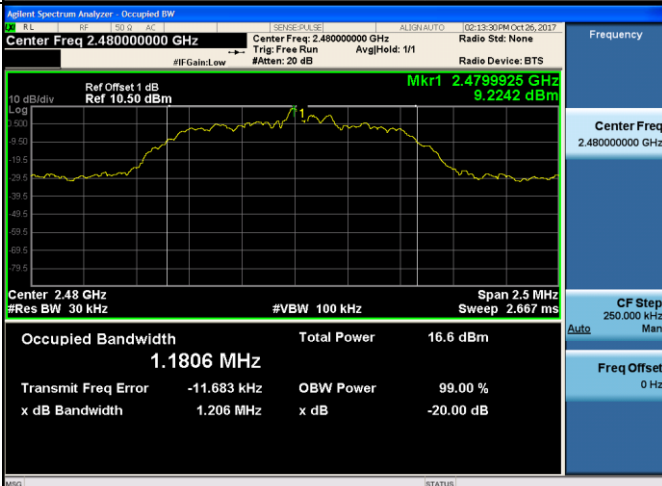
Please refer to the clause 3.3

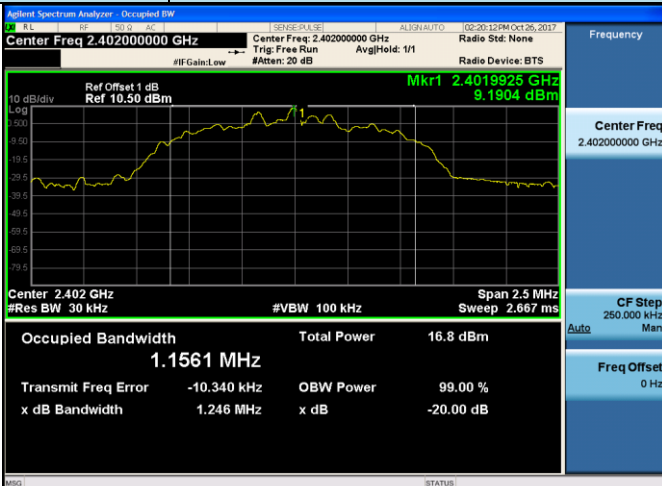
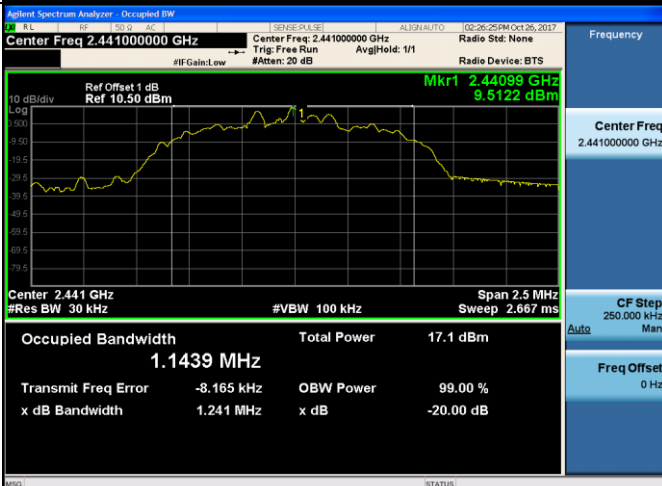
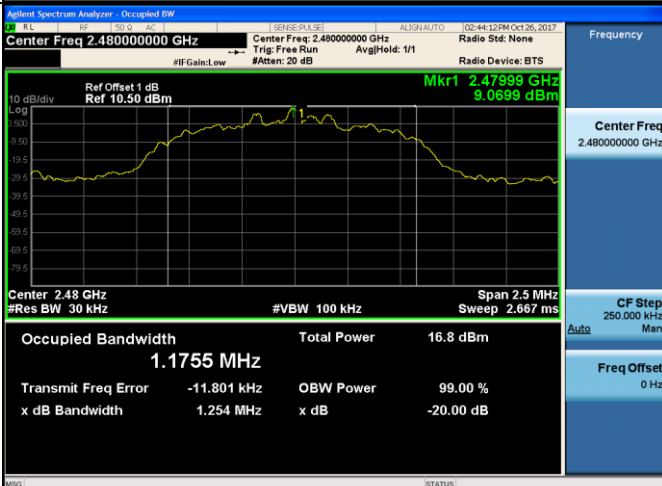
TEST RESULTS

☒ **Passed** ☐ **Not Applicable**

Modulation type	Channel	20dB Bandwidth (MHz)	Limit (MHz)	Result
GFSK	00	1.030	-	Pass
	39	1.030		
	78	0.9990		
$\pi/4$ DQPSK	00	1.199	-	Pass
	39	1.189		
	78	1.206		
8DPSK	00	1.246	-	Pass
	39	1.241		
	78	1.254		

Modulation Type:	GFSK
CH00	 Agilent Spectrum Analyzer - Occupied BW Center Freq 2.40200000 GHz Ref Offset 1 dB Ref 10.50 dBm Mkr1 2.401982 GHz 3.9469 dBm Center 2.402 GHz #Res BW 10 kHz Span 2 MHz #VBW 30 kHz Sweep 19.13 ms Occupied Bandwidth 927.21 kHz Total Power 16.1 dBm Transmit Freq Error -7.165 kHz OBW Power 99.00 % x dB Bandwidth 1.030 MHz x dB -20.00 dB Frequency Center Freq 2.40200000 GHz CF Step 200.000 kHz Freq Offset 0 Hz
CH39	 Agilent Spectrum Analyzer - Occupied BW Center Freq 2.44100000 GHz Ref Offset 1 dB Ref 10.50 dBm Mkr1 2.440986 GHz 4.2315 dBm Center 2.441 GHz #Res BW 10 kHz Span 2 MHz #VBW 30 kHz Sweep 19.13 ms Occupied Bandwidth 924.74 kHz Total Power 16.4 dBm Transmit Freq Error -7.849 kHz OBW Power 99.00 % x dB Bandwidth 1.030 MHz x dB -20.00 dB Frequency Center Freq 2.44100000 GHz CF Step 200.000 kHz Freq Offset 0 Hz
CH78	 Agilent Spectrum Analyzer - Occupied BW Center Freq 2.48000000 GHz Ref Offset 1 dB Ref 10.50 dBm Mkr1 2.479986 GHz 3.7427 dBm Center 2.48 GHz #Res BW 10 kHz Span 2 MHz #VBW 30 kHz Sweep 19.13 ms Occupied Bandwidth 919.27 kHz Total Power 16.0 dBm Transmit Freq Error -6.256 kHz OBW Power 99.00 % x dB Bandwidth 999.0 kHz x dB -20.00 dB Frequency Center Freq 2.48000000 GHz CF Step 200.000 kHz Freq Offset 0 Hz

Modulation Type:		π/4DQPSK	
CH00		Frequency Center Freq 2.402000000 GHz CF Step 250.000 kHz Man Freq Offset 0 Hz	
CH39		Frequency Center Freq 2.441000000 GHz CF Step 250.000 kHz Man Freq Offset 0 Hz	
CH78		Frequency Center Freq 2.480000000 GHz CF Step 250.000 kHz Man Freq Offset 0 Hz	

Modulation Type:		8DPSK	
CH00			
CH39			
CH78			

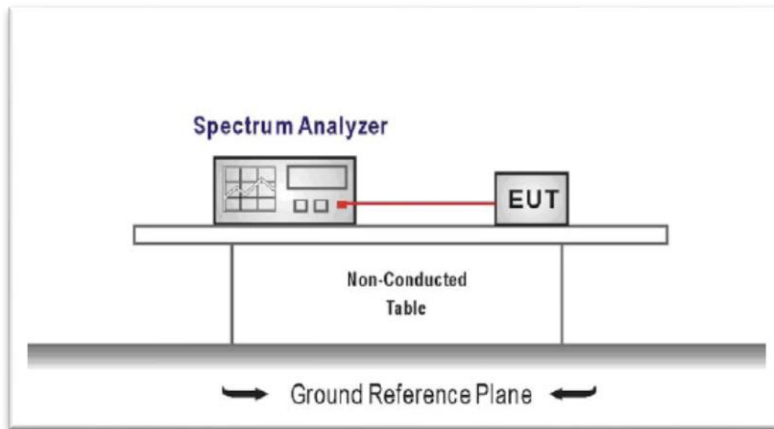
5.5. Carrier Frequencies Separation

LIMIT

FCC CFR Title 47 Part 15 Subpart C Section 15.247 (a)(1):

frequency hopping systems shall have hopping channel carrier frequencies separated by minimum of 25KHz or the $\frac{2}{3} \times 20\text{dB}$ bandwidth of the hopping channel, whichever is greater.

TEST CONFIGURATION



TEST PROCEDURE

1. The transmitter output was connected to the spectrum analyzer through an attenuator, the pathloss was compensated to the results for each measurement.
2. Set to the maximum power setting and enable the EUT transmit continuously
3. Use the following spectrum analyzer settings:
Span = wide enough to capture the peaks of two adjacent channels
RBW $\geq 1\%$ of the span, VBW $\geq$ RBW
Sweep = auto, Detector function = peak, Trace = max hold
4. Measure and record the results in the test report.

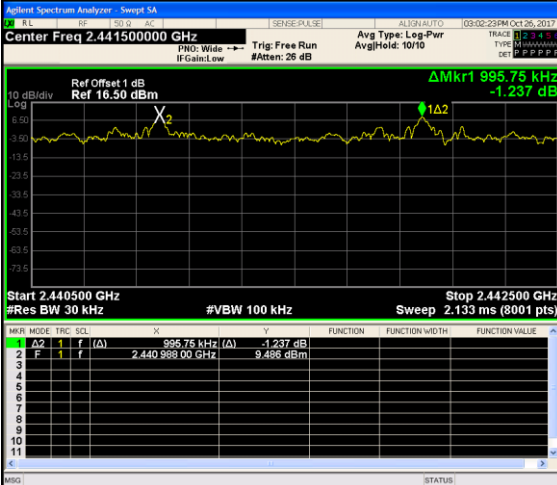
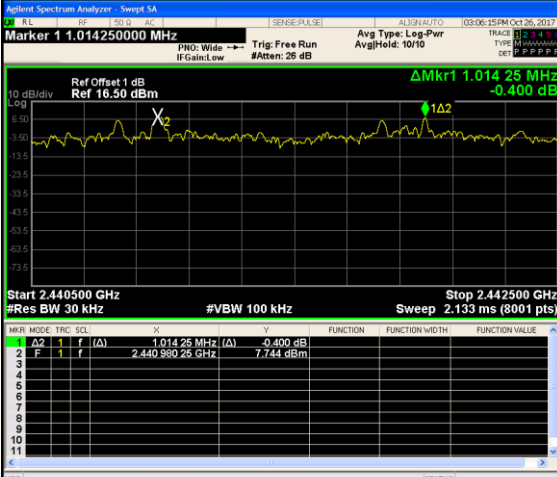
TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

☒ Passed ☐ Not Applicable

Modulation type	Channel	Carrier Frequencies Separation (MHz)	Limit (MHz)	Result
GFSK	39	0.998	≥ 0.932	Pass
$\pi/4$ DQPSK	39	0.996	≥ 0.861	Pass
8DPSK	39	1.014	≥ 0.854	Pass

GFSK	 Agilent Spectrum Analyzer - Sweep SA Marker 1 997.750000 kHz Ref Offset: 1 dB Ref: 16.50 dBm ΔMkr1 997.75 kHz -0.271 dB Start 2.440500 GHz #Res BW 30 kHz #VBW 100 kHz Stop 2.442500 GHz Sweep 2.133 ms (8001 pts) <table><tr><th>MKR</th><th>MODE</th><th>TRIG</th><th>SCL</th><th>X</th><th>Y</th><th>FUNCTION</th><th>FUNCTION WIDTH</th><th>FUNCTION VALUE</th></tr><tr><td>1</td><td>Δ2</td><td>1</td><td>f</td><td>(Δ)</td><td>997.75 kHz (Δ)</td><td>-0.271 dB</td><td></td><td></td></tr><tr><td>2</td><td>F</td><td>1</td><td>f</td><td></td><td>2.440 999 25 GHz</td><td>6.384 dBm</td><td></td><td></td></tr></table>	MKR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE	1	Δ 2	1	f	(Δ)	997.75 kHz (Δ)	-0.271 dB			2	F	1	f		2.440 999 25 GHz	6.384 dBm			Peak Search Next Peak Next Pk Right Next Pk Left Marker Delta Mkr--CF Mkr--Ref Lvl More 1 of 2
MKR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE																					
1	Δ 2	1	f	(Δ)	997.75 kHz (Δ)	-0.271 dB																							
2	F	1	f		2.440 999 25 GHz	6.384 dBm																							
π /4DQPSK	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441500000 GHz Ref Offset: 1 dB Ref: 16.50 dBm ΔMkr1 995.75 kHz -1.237 dB Start 2.440500 GHz #Res BW 30 kHz #VBW 100 kHz Stop 2.442500 GHz Sweep 2.133 ms (8001 pts) <table><tr><th>MKR</th><th>MODE</th><th>TRIG</th><th>SCL</th><th>X</th><th>Y</th><th>FUNCTION</th><th>FUNCTION WIDTH</th><th>FUNCTION VALUE</th></tr><tr><td>1</td><td>Δ2</td><td>1</td><td>f</td><td>(Δ)</td><td>995.75 kHz (Δ)</td><td>-1.237 dB</td><td></td><td></td></tr><tr><td>2</td><td>F</td><td>1</td><td>f</td><td></td><td>2.440 999 00 GHz</td><td>9.486 dBm</td><td></td><td></td></tr></table>	MKR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE	1	Δ 2	1	f	(Δ)	995.75 kHz (Δ)	-1.237 dB			2	F	1	f		2.440 999 00 GHz	9.486 dBm			Frequency Auto Tune Center Freq 2.441500000 GHz Start Freq 2.440500000 GHz Stop Freq 2.442500000 GHz CF Step 200.000 kHz Freq Offset 0 Hz
MKR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE																					
1	Δ 2	1	f	(Δ)	995.75 kHz (Δ)	-1.237 dB																							
2	F	1	f		2.440 999 00 GHz	9.486 dBm																							
8DPSK	 Agilent Spectrum Analyzer - Sweep SA Marker 1 1.014250000 MHz Ref Offset: 1 dB Ref: 16.50 dBm ΔMkr1 1.014 25 MHz -0.400 dB Start 2.440500 GHz #Res BW 30 kHz #VBW 100 kHz Stop 2.442500 GHz Sweep 2.133 ms (8001 pts) <table><tr><th>MKR</th><th>MODE</th><th>TRIG</th><th>SCL</th><th>X</th><th>Y</th><th>FUNCTION</th><th>FUNCTION WIDTH</th><th>FUNCTION VALUE</th></tr><tr><td>1</td><td>Δ2</td><td>1</td><td>f</td><td>(Δ)</td><td>1.014 25 MHz (Δ)</td><td>-0.400 dB</td><td></td><td></td></tr><tr><td>2</td><td>F</td><td>1</td><td>f</td><td></td><td>2.440 999 25 GHz</td><td>7.744 dBm</td><td></td><td></td></tr></table>	MKR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE	1	Δ 2	1	f	(Δ)	1.014 25 MHz (Δ)	-0.400 dB			2	F	1	f		2.440 999 25 GHz	7.744 dBm			Peak Search Next Peak Next Pk Right Next Pk Left Marker Delta Mkr--CF Mkr--Ref Lvl More 1 of 2
MKR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE																					
1	Δ 2	1	f	(Δ)	1.014 25 MHz (Δ)	-0.400 dB																							
2	F	1	f		2.440 999 25 GHz	7.744 dBm																							

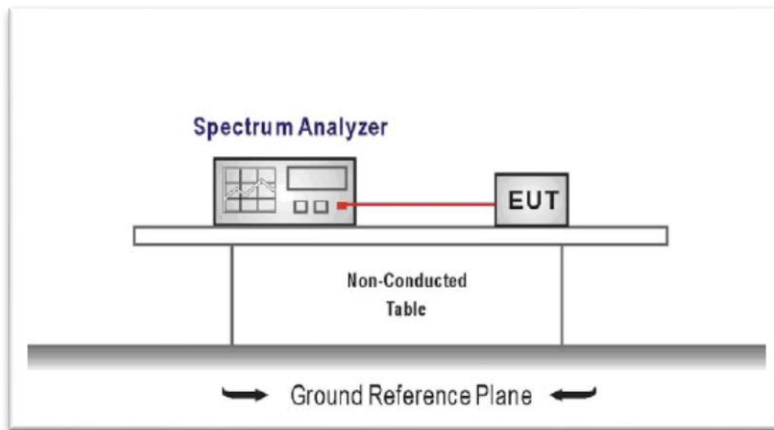
5.6. Hopping Channel Number

LIMIT

FCC CFR Title 47 Part 15 Subpart C Section 15.247 (a)(1):

Frequency hopping systems in the 2400–2483.5 MHz band shall use at least **15** channels.

TEST CONFIGURATION



TEST PROCEDURE

1. The transmitter output was connected to the spectrum analyzer through an attenuator, the pathloss was compensated to the results for each measurement.
2. Set to the maximum power setting and enable the EUT transmit continuously
3. Use the following spectrum analyzer settings:
Span = the frequency band of operation
RBW $\geq 1\%$ of the span, VBW $\geq$ RBW
Sweep = auto, Detector function = peak, Trace = max hold
4. Measure and record the results in the test report.

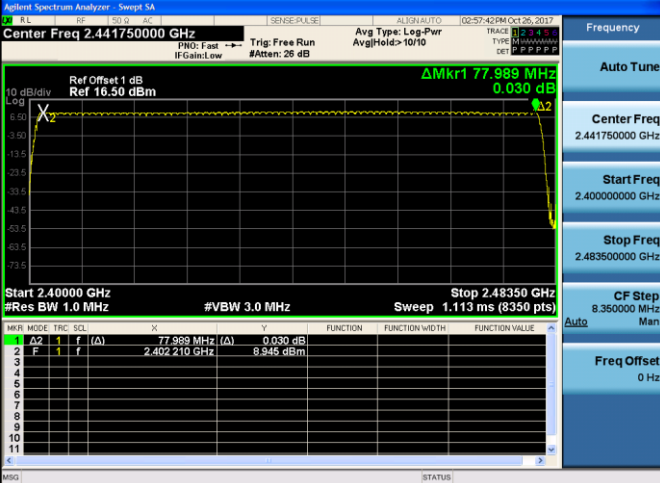
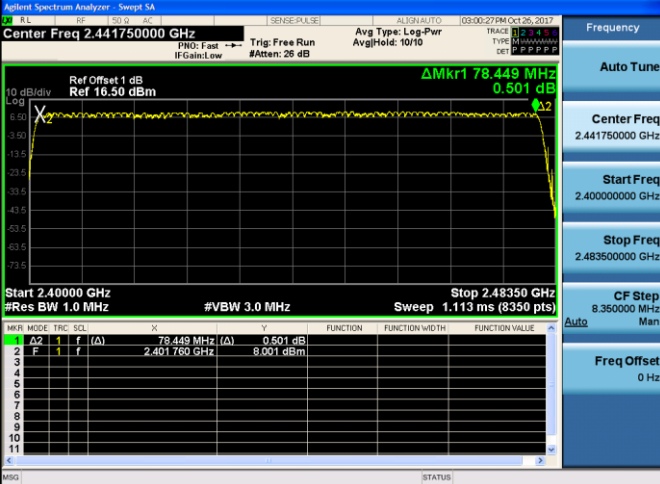
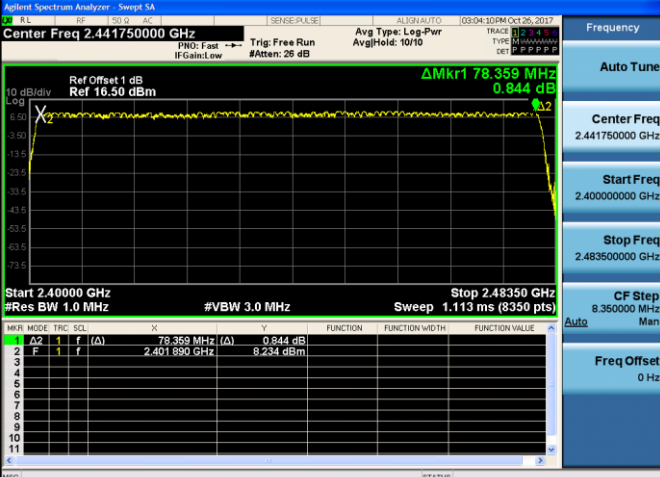
TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

☒ Passed ☐ Not Applicable

Modulation type	Channel number	Limit	Result
GFSK	79	15	Pass
$\pi/4$ DQPSK	79		
8DPSK	79		

GFSK		
$\pi/4$ DQPSK		
8DPSK		

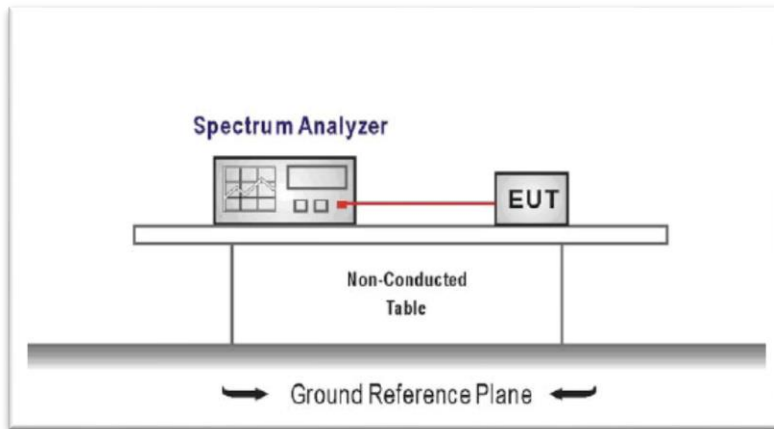
5.7. Dwell Time

LIMIT

FCC CFR Title 47 Part 15 Subpart C Section 15.247 (a)(1):

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a pe-riod of 0.4 seconds multiplied by the number of hopping channels employed.

TEST CONFIGURATION



TEST PROCEDURE

1. The transmitter output was connected to the spectrum analyzer through an attenuator, the pathloss was compensated to the results for each measurement.
2. Set to the maximum power setting and enable the EUT transmit continuously
3. Use the following spectrum analyzer settings:
Span = zero span, centered on a hopping channel, RBW= 1 MHz, VBW≥RBW
Sweep = as necessary to capture the entire dwell time per hopping channel,
Detector function = peak, Trace = max hold
4. Measure and record the results in the test report.

TEST MODE:

Please refer to the clause 3.3

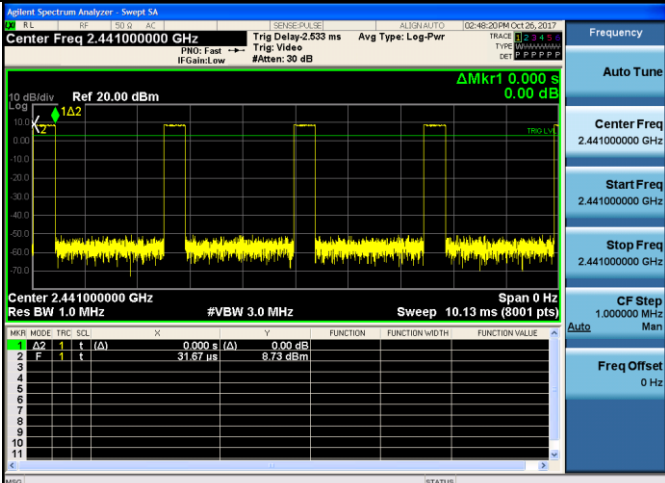
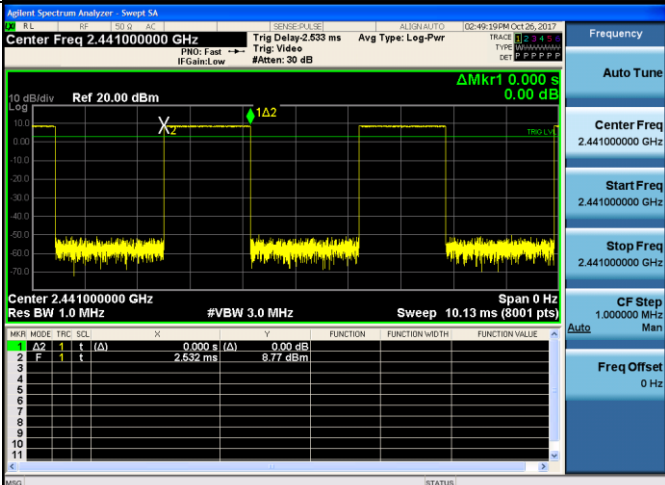
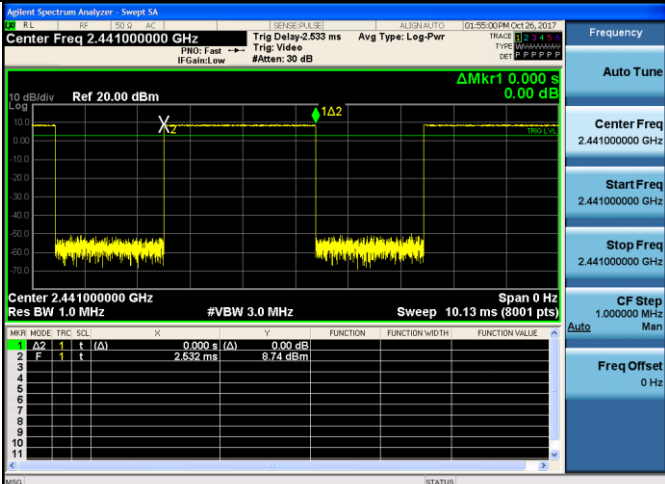
TEST RESULTS

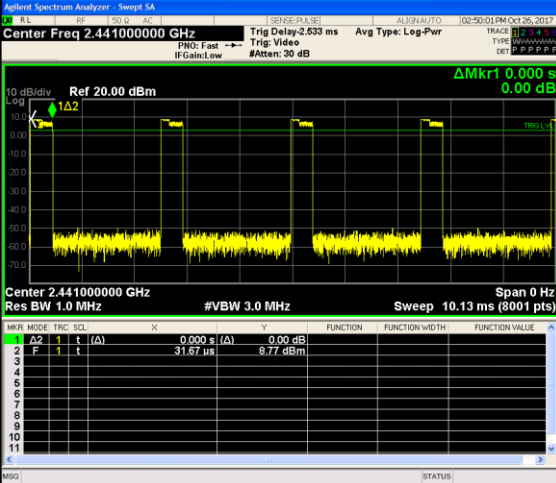
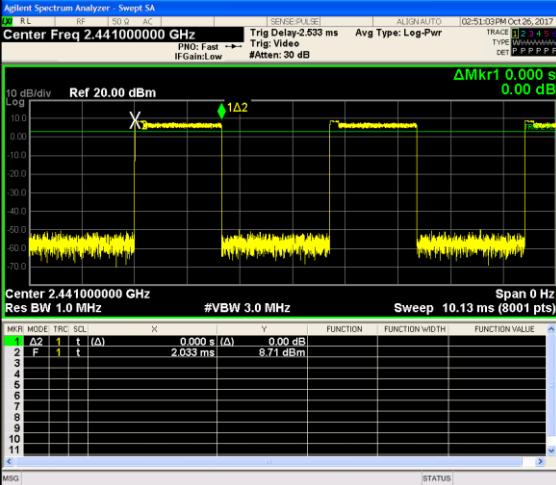
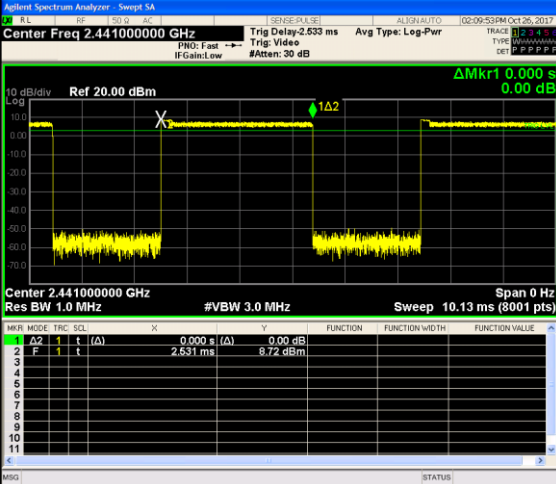
☒ Passed ☐ Not Applicable

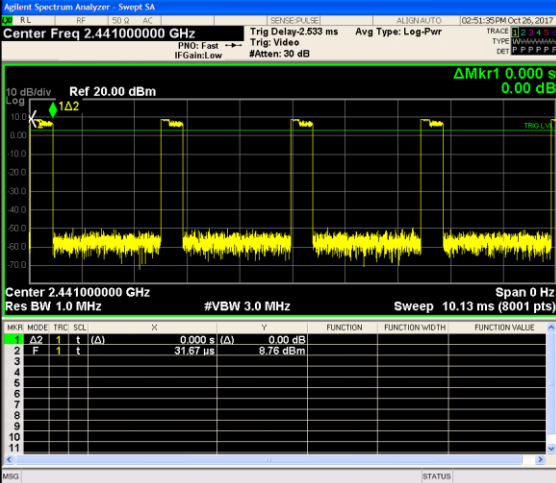
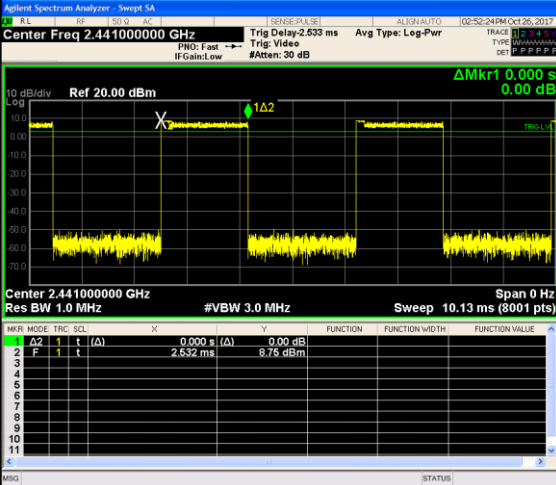
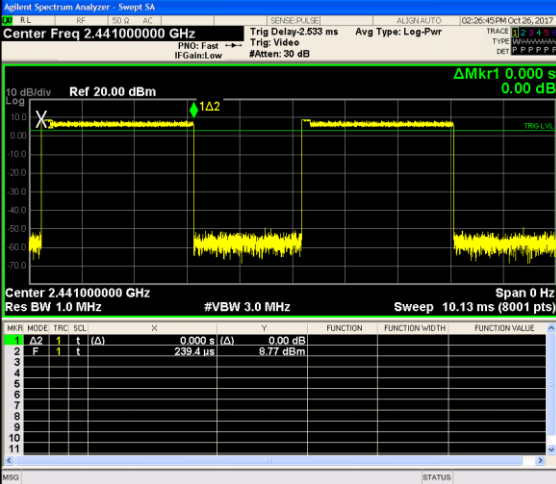
Modulation type	Channel	Dwell time (Second)	Limit (Second)	Result
GFSK	DH1	0.131	0.40	Pass
	DH3	0.267		
	DH5	0.310		
π/4DQPSK	2-DH1	0.134	0.40	Pass
	2-DH3	0.267		
	2-DH5	0.312		
8DPSK	3-DH1	0.134	0.40	Pass
	3-DH3	0.267		
	3-DH5	0.312		

Note:

1. We have tested all mode at high,middle and low channel,and recoreded worst case at middle channel.
2. Dwell time=Pulse time (ms) × (1600 ÷ 2 ÷ 79) ×31.6 Second for DH1, 2-DH1, 3-DH1
Dwell time=Pulse time (ms) × (1600 ÷ 4 ÷ 79) ×31.6 Second for DH3, 2-DH3, 3-DH3
Dwell time=Pulse time (ms) × (1600 ÷ 6 ÷ 79) ×31.6 Second for DH5, 2-DH5, 3-DH5

Modulation Type:		GFSK																										
DH1	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441000000 GHz Ref 20.00 dBm Trig Delay: 2.533 ms Avg Type: Log-Pwr Trig: Video #Atten: 30 dB ΔMkr1 0.000 s 0.00 dB Center 2.441000000 GHz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8001 pts) Span 0 Hz CF Step 1.000000 MHz Freq Offset 0 Hz <table><tr><th>MNR</th><th>MODE</th><th>TRIG</th><th>SCL</th><th>X</th><th>Y</th><th>FUNCTION</th><th>FUNCTION WIDTH</th><th>FUNCTION VALUE</th></tr><tr><td>1</td><td>Δ2</td><td>1</td><td>t</td><td>(Δ)</td><td>0.000 s</td><td>(Δ)</td><td>0.00 dB</td><td></td></tr><tr><td>2</td><td>F</td><td>1</td><td>t</td><td>(Δ)</td><td>31.67 μs</td><td>9.73 dBm</td><td></td><td></td></tr></table>	MNR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE	1	Δ2	1	t	(Δ)	0.000 s	(Δ)	0.00 dB		2	F	1	t	(Δ)	31.67 μs	9.73 dBm		
MNR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE																				
1	Δ2	1	t	(Δ)	0.000 s	(Δ)	0.00 dB																					
2	F	1	t	(Δ)	31.67 μs	9.73 dBm																						
DH3	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441000000 GHz Ref 20.00 dBm Trig Delay: 2.533 ms Avg Type: Log-Pwr Trig: Video #Atten: 30 dB ΔMkr1 0.000 s 0.00 dB Center 2.441000000 GHz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8001 pts) Span 0 Hz CF Step 1.000000 MHz Freq Offset 0 Hz <table><tr><th>MNR</th><th>MODE</th><th>TRIG</th><th>SCL</th><th>X</th><th>Y</th><th>FUNCTION</th><th>FUNCTION WIDTH</th><th>FUNCTION VALUE</th></tr><tr><td>1</td><td>Δ2</td><td>1</td><td>t</td><td>(Δ)</td><td>0.000 s</td><td>(Δ)</td><td>0.00 dB</td><td></td></tr><tr><td>2</td><td>F</td><td>1</td><td>t</td><td>(Δ)</td><td>2.632 ms</td><td>9.77 dBm</td><td></td><td></td></tr></table>	MNR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE	1	Δ2	1	t	(Δ)	0.000 s	(Δ)	0.00 dB		2	F	1	t	(Δ)	2.632 ms	9.77 dBm		
MNR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE																				
1	Δ2	1	t	(Δ)	0.000 s	(Δ)	0.00 dB																					
2	F	1	t	(Δ)	2.632 ms	9.77 dBm																						
DH5	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441000000 GHz Ref 20.00 dBm Trig Delay: 2.533 ms Avg Type: Log-Pwr Trig: Video #Atten: 30 dB ΔMkr1 0.000 s 0.00 dB Center 2.441000000 GHz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8001 pts) Span 0 Hz CF Step 1.000000 MHz Freq Offset 0 Hz <table><tr><th>MNR</th><th>MODE</th><th>TRIG</th><th>SCL</th><th>X</th><th>Y</th><th>FUNCTION</th><th>FUNCTION WIDTH</th><th>FUNCTION VALUE</th></tr><tr><td>1</td><td>Δ2</td><td>1</td><td>t</td><td>(Δ)</td><td>0.000 s</td><td>(Δ)</td><td>0.00 dB</td><td></td></tr><tr><td>2</td><td>F</td><td>1</td><td>t</td><td>(Δ)</td><td>2.632 ms</td><td>9.74 dBm</td><td></td><td></td></tr></table>	MNR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE	1	Δ2	1	t	(Δ)	0.000 s	(Δ)	0.00 dB		2	F	1	t	(Δ)	2.632 ms	9.74 dBm		
MNR	MODE	TRIG	SCL	X	Y	FUNCTION	FUNCTION WIDTH	FUNCTION VALUE																				
1	Δ2	1	t	(Δ)	0.000 s	(Δ)	0.00 dB																					
2	F	1	t	(Δ)	2.632 ms	9.74 dBm																						

Modulation Type:	$\pi/4$ DQPSK
2DH1	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441000000 GHz Ref 20.00 dBm 0.00 dB 10 dB/div Log Center 2.441000000 GHz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8001 pts) Span 0 Hz CF Step 1.000000 MHz Freq Offset 0 Hz
2DH3	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441000000 GHz Ref 20.00 dBm 0.00 dB 10 dB/div Log Center 2.441000000 GHz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8001 pts) Span 0 Hz CF Step 1.000000 MHz Freq Offset 0 Hz
2DH5	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441000000 GHz Ref 20.00 dBm 0.00 dB 10 dB/div Log Center 2.441000000 GHz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8001 pts) Span 0 Hz CF Step 1.000000 MHz Freq Offset 0 Hz

Modulation Type:	8DPSK
3DH1	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441000000 GHz Ref 20.00 dBm ΔMkr1 0.000 s 0.00 dB Center 2.441000000 GHz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8001 pts) Span 0 Hz CF Step 1.000000 MHz Freq Offset 0 Hz
3DH3	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441000000 GHz Ref 20.00 dBm ΔMkr1 0.000 s 0.00 dB Center 2.441000000 GHz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8001 pts) Span 0 Hz CF Step 1.000000 MHz Freq Offset 0 Hz
3DH5	 Agilent Spectrum Analyzer - Sweep SA Center Freq 2.441000000 GHz Ref 20.00 dBm ΔMkr1 0.000 s 0.00 dB Center 2.441000000 GHz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8001 pts) Span 0 Hz CF Step 1.000000 MHz Freq Offset 0 Hz

5.8. Pseudorandom Frequency Hopping Sequence

LIMIT

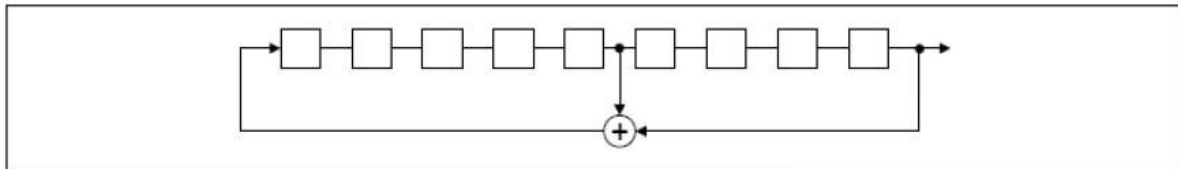
FCC CFR Title 47 Part 15 Subpart C Section 15.247 (a)(1):

Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400–2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW. The system shall hop to channel frequencies that are selected at the system hopping rate from a pseudo randomly ordered list of hopping frequencies. Each frequency must be used equally on the average by each transmitter. The system receivers shall have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.

TEST RESULTS

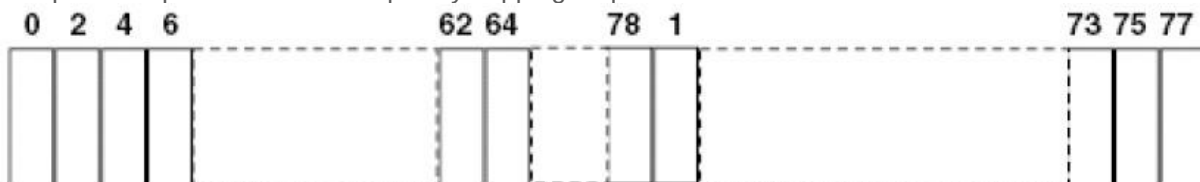
The pseudorandom frequency hopping sequence may be generated in a nine-stage shift register whose 5th and 9th stage outputs are added in a modulo-two addition stage. And the result is fed back to the input of the first stage. The sequence begins with the first one of 9 consecutive ones, for example: the shift register is initialized with nine ones.

- Number of shift register stages: 9
- Length of pseudo-random sequence: $2^9 - 1 = 511$ bits
- Longest sequence of zeros: 8 (non-inverted signal)



Linear Feedback Shift Register for Generation of the PRBS sequence

An example of pseudorandom frequency hopping sequence as follows:



Each frequency used equally one the average by each transmitter.

The system receiver have input bandwidths that match the hopping channel bandwidths of their corresponding transmitter and shift frequencies in synchronization with the transmitted signals.

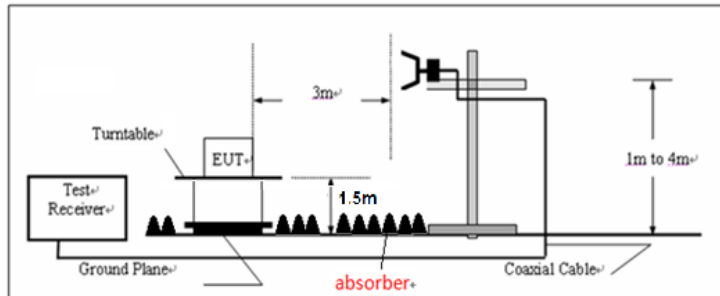
5.9. Restricted band (radiated)

LIMIT

FCC CFR Title 47 Part 15 Subpart C Section 15.247 (d):

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

TEST CONFIGURATION



TEST PROCEDURE

1. The EUT was setup and tested according to ANSI C63.10:2013 for compliance to FCC 47CFR 15.247 requirements.
2. The EUT is placed on a turn table which is 1.5 meter above ground. The turn table is rotated 360 degrees to determine the position of the maximum emission level.
3. The EUT was positioned such that the distance from antenna to the EUT was 3 meters.
4. The antenna is scanned from 1 meter to 4 meters to find out the maximum emission level. This is repeated for both horizontal and vertical polarization of the antenna. In order to find the maximum emission, all of the interface cables were manipulated according to ANSI C63.10:2013 on radiated measurement.
5. The receiver set as follow:
 RBW=1MHz, VBW=3MHz Peak detector for Peak value
 RBW=1MHz, VBW=10Hz Peak detector for Average value.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

☒ **Passed** ☐ **Not Applicable**

Note:

- 1) *Final level= Read level + Antenna Factor+ Cable Loss- Preamp Factor*
- 2) *Have pre-scan all modulation mode, found the GFSK modulation which it was worst case, so only the worst case's data on the test report.*

BT-EDR						CH00			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamplifier Factor (dB)	Level (dBuV/m)	Limit Line (dBuV/m)	Margin Limit (dB)	Polarization	Test value
2310.00	34.38	28.05	6.62	37.65	31.40	74.00	-42.60	Horizontal	Peak
2390.03	37.63	27.65	6.75	37.87	34.16	74.00	-39.84	Horizontal	Peak
2310.00	32.88	28.05	6.62	37.65	29.90	74.00	-44.10	Vertical	Peak
2390.03	39.53	27.65	6.75	37.87	36.06	74.00	-37.94	Vertical	Peak
2310.00	22.35	28.05	6.62	37.65	19.37	54.00	-34.63	Horizontal	Average
2390.03	22.01	27.65	6.75	37.87	18.54	54.00	-35.46	Horizontal	Average
2310.00	22.40	28.05	6.62	37.65	19.42	54.00	-34.58	Vertical	Average
2390.03	22.48	27.65	6.75	37.87	19.01	54.00	-34.99	Vertical	Average

BT-EDR						CH78			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamplifier Factor (dB)	Level (dBuV/m)	Limit Line (dBuV/m)	Margin Limit (dB)	Polarization	Test value
2483.50	34.74	27.26	6.83	37.87	30.96	74.00	-43.04	Horizontal	Peak
2491.22	52.40	27.23	6.83	37.87	48.59	74.00	-25.41	Horizontal	Peak
2500.00	34.08	27.20	6.84	37.87	30.25	74.00	-43.75	Horizontal	Peak
2483.50	40.74	27.26	6.83	37.87	36.96	74.00	-37.04	Vertical	Peak
2494.60	63.43	27.22	6.84	37.87	59.62	74.00	-14.38	Vertical	Peak
2500.00	40.14	27.20	6.84	37.87	36.31	74.00	-37.69	Vertical	Peak
2483.50	23.40	27.26	6.83	37.87	19.62	54.00	-34.38	Horizontal	Average
2500.00	22.19	27.20	6.84	37.87	18.36	54.00	-35.64	Horizontal	Average
2483.50	24.81	27.26	6.83	37.87	21.03	54.00	-32.97	Vertical	Average
2500.00	21.46	27.20	6.84	37.87	17.63	54.00	-36.37	Vertical	Average

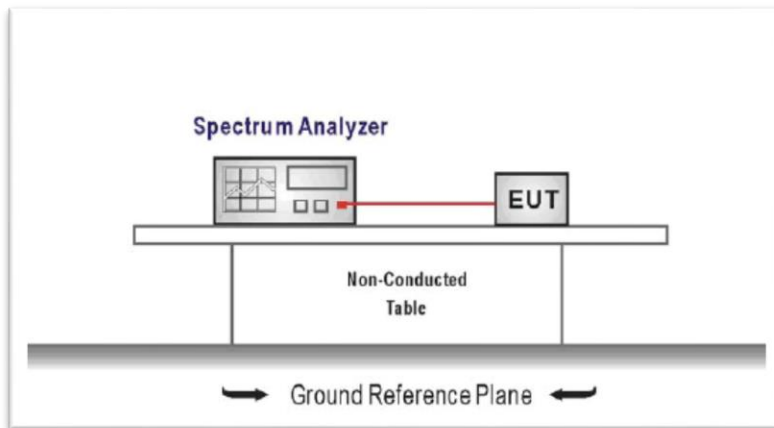
5.10. Bandedge and Spurious Emission (conducted)

LIMIT

FCC CFR Title 47 Part 15 Subpart C Section 15.247 (d):

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.

TEST CONFIGURATION



TEST PROCEDURE

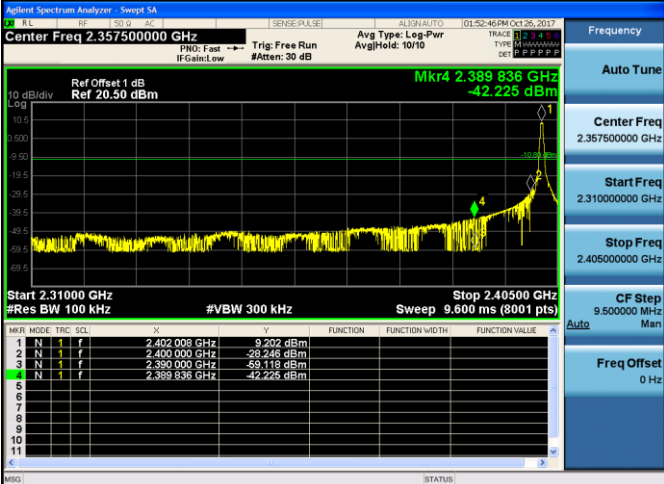
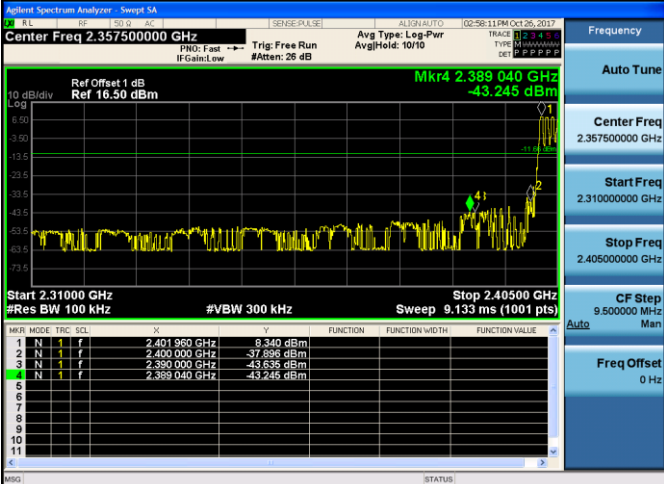
1. The transmitter output was connected to the spectrum analyzer through an attenuator, the pathloss was compensated to the results for each measurement.
2. Set to the maximum power setting and enable the EUT transmit continuously
3. Use the following spectrum analyzer settings:
RBW= 100 KHz, VBW $\geq$ RBW
Sweep = auto, Detector function = peak, Trace = max hold
4. Measure and record the results in the test report.

TEST MODE:

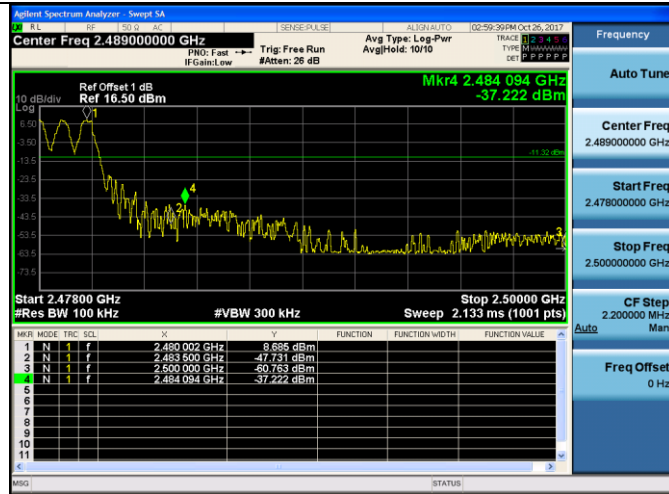
Please refer to the clause 3.3

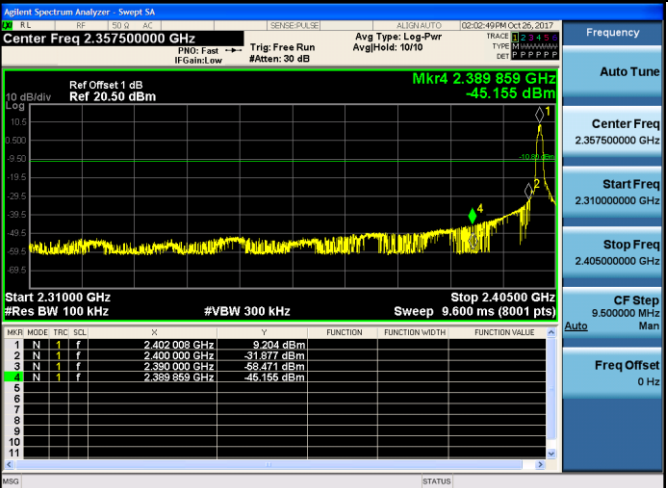
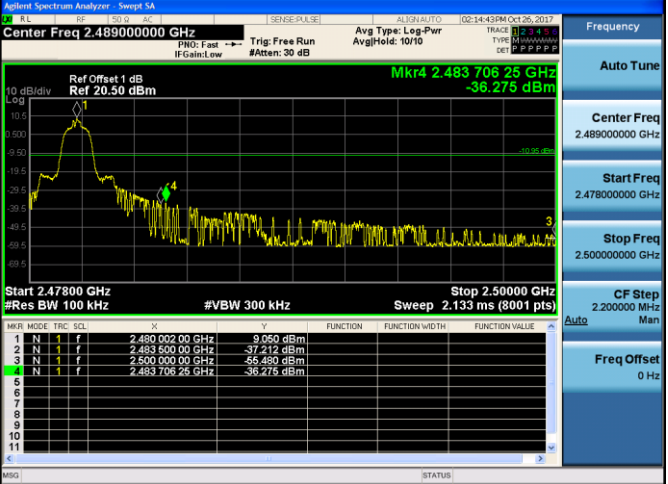
TEST RESULTS

☒ Passed ☐ Not Applicable

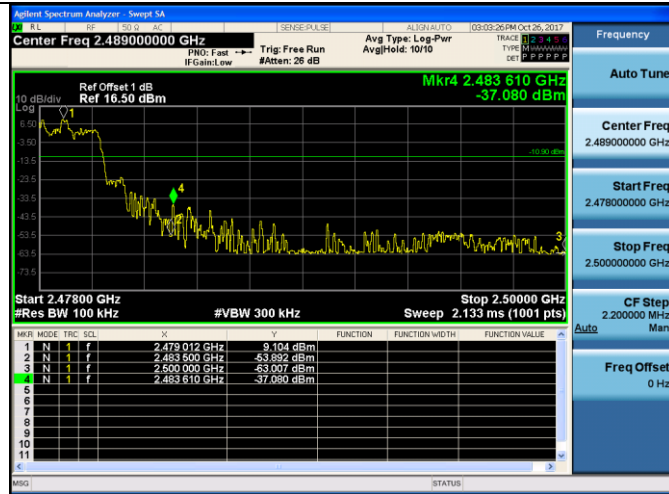
Test Item:	Band edge	Modulation type:	GFSK
CH00 No hopping mode			
CH00 Hopping mode			
CH78 No hopping mode			

CH78
Hopping mode



Test Item:	Band edge	Modulation type:	$\pi/4$ DQPSK
CH00 No hopping mode			
CH00 Hopping mode			
CH78 No hopping mode			

CH78
Hopping mode



Test Item:	Band edge	Modulation type:	8DPSK
CH00 No hopping mode			
CH00 Hopping mode			
CH78 No hopping mode			

CH78
Hoppig mode

